MOSFET – Power, N-Channel 60 V, 20 A, 39 mΩ

Features

- Low R_{DS(on)}
- High Current Capability
- 100% Avalanche Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage - Continuous			V_{GS}	±20	V
Gate-to-Source Voltage - Non-Repetitive (t _p < 10 μs)			V_{GS}	±30	٧
Continuous Drain		T _C = 25°C	I _D	20	Α
Current (R _{θJC})	Steady	T _C = 100°C		13	
Power Dissipation ($R_{\theta JC}$)	State	T _C = 25°C	P _D	36	W
Pulsed Drain Current	t _p =	= 10 μs	I _{DM}	76	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 150	°C
Source Current (Body I	Source Current (Body Diode)			20	Α
Single Pulse Drain-to-Source Avalanche Energy (V _{DD} = 50 V, V _{GS} = 10 V, R _G = 25 Ω , I _{L(pk)} = 19 A, L = 0.1 mH, T _J = 25 $^{\circ}$ C)			E _{AS}	18	mJ
Lead Temperature for S (1/8" from case for 10 s		Purposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	3.5	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	45	

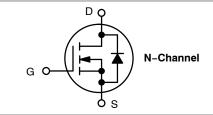
 Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
60 V	39 m Ω @ 10 V	20 A
	50 mΩ @ 4.5 V	18 A



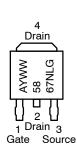


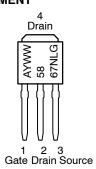
DPAK CASE 369AA (Surface Mount) STYLE 2



IPAK CASE 369D (Straight Lead) STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENT





A = Assembly Location*

Y = Year WW = Work Week 5867NL = Device Code G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

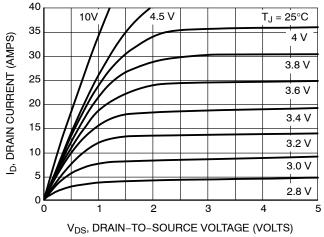
Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				•	•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	= 250 μA	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				60		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		$V_{DS} = 60 \text{ V}$	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	s = ±20 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D :	= 250 μΑ	1.5	1.8	2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	₎ = 10 A		26	39	mΩ
		V _{GS} = 4.5 V, I _E	_O = 10 A		33	50	
Forward Transconductance	9FS	V _{DS} = 15 V, I _D	₎ = 10 A		8.0		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCES				•	•	
Input Capacitance	C _{iss}				675		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f} = 0 \text{ V}$ $V_{DS} = 25 \text{ V}$	1.0 MHz,		68		1
Reverse Transfer Capacitance	C _{rss}	VDS - 20	, v		47		1
Total Gate Charge	Q _{G(TOT)}				15		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _D	c = 48 V		1.0		1
Gate-to-Source Charge	Q _{GS}	$I_{D} = 20 \text{ A}$			2.2		1
Gate-to-Drain Charge	Q_{GD}				4.3		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{D}$ $I_{D} = 20$	os = 48 V, A		7.6		nC
Gate Resistance	R_{G}				1.3		Ω
SWITCHING CHARACTERISTICS (Note 3)	•				•	•	
Turn-On Delay Time	$t_{d(on)}$				6.5		ns
Rise Time	t _r	V _{GS} = 10 V, V _D	n = 48 V		12.6		-
Turn-Off Delay Time	t _{d(off)}	$I_D = 20 \text{ A}, R_G$			18.2		
Fall Time	t _f				2.4		
DRAIN-SOURCE DIODE CHARACTERISTIC	S						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.87	1.2	V
		$I_S = 10 \text{ A}$	T _J = 100°C		0.78		1
Reverse Recovery Time	t _{RR}		<u> </u>		17		ns
Charge Time	ta	V _{GS} = 0 V, dls/dt	– 100 Δ/us		13		1
Discharge Time	tb	$V_{GS} = 0$ V, dis/dis			4.0		1
Reverse Recovery Charge	Q _{RR}	1			12		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

3. Switching characteristics are independent of operating junction temperatures.

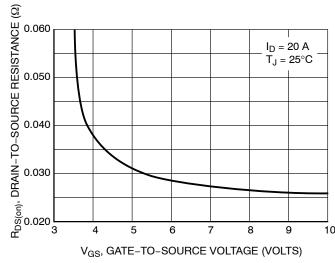
TYPICAL PERFORMANCE CURVES



40 $V_{DS} \ge 10 \text{ V}$ 35 **DRAIN CURRENT (AMPS)** 30 25 20 15 $T_J = 125^{\circ}C$ 10 $T_J = 25^{\circ}C$ Õ $T_J = -55^{\circ}C$ 0<u>L</u> 3 5 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



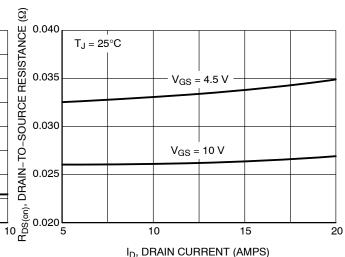
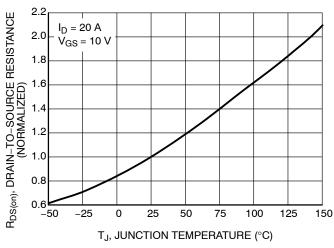


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



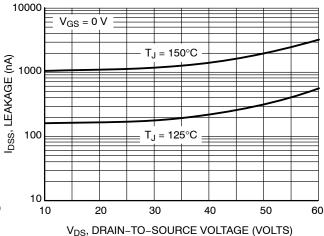


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES

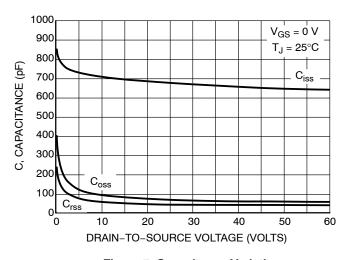


Figure 7. Capacitance Variation

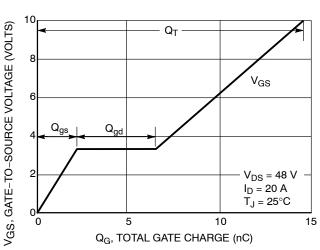


Figure 8. Gate-To-Source Voltage vs.
Total Charge

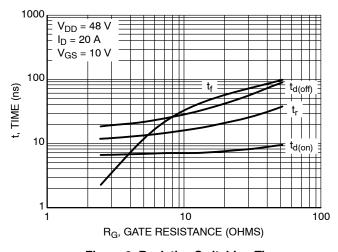


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

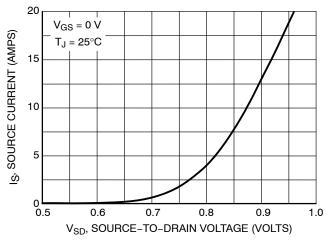


Figure 10. Diode Forward Voltage vs. Current

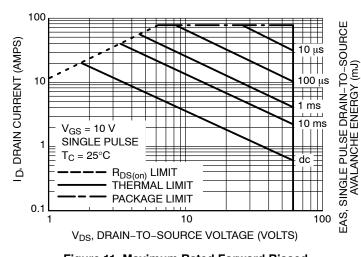


Figure 11. Maximum Rated Forward Biased Safe Operating Area

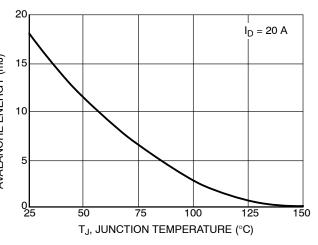


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

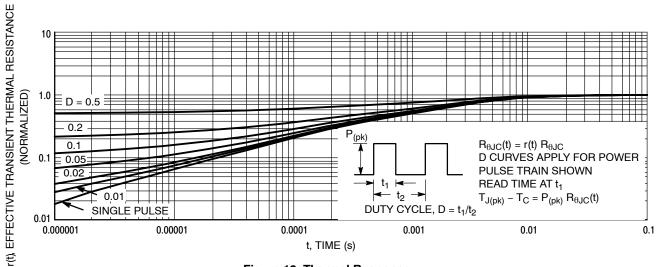


Figure 13. Thermal Response

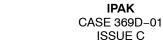
ORDERING INFORMATION

Order Number	Package	Shipping [†]
NTD5867NL-1G	IPAK (Straight Lead) (Pb-Free)	75 Units / Rail
NTD5867NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MECHANICAL CASE OUTLINE





STYLE 3: PIN 1. ANODE

2. CATHODE

4. CATHODE

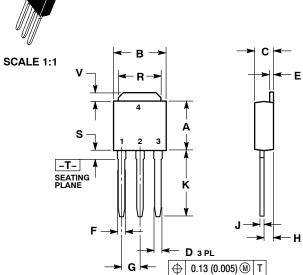
3 ANODE

STYLE 7: PIN 1. GATE 2. COLLECTOR

3. EMITTER

COLLECTOR

DATE 15 DEC 2010



STYLE 2:

PIN 1. GATE

3

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

2. DRAIN

4. DRAIN

MT2

SOURCE

STYLE 1: PIN 1. BASE

3

STYLE 5: PIN 1. GATE

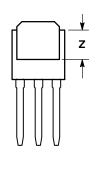
2. ANODE 3. CATHODE

ANODE

2. COLLECTOR

EMITTER

COLLECTOR



NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

MARKING DIAGRAMS

STYLE 4:
PIN 1. CATHODE
2. ANODE
3. GATE
4. ANODE
Discrete

XXXXX

ALYWW

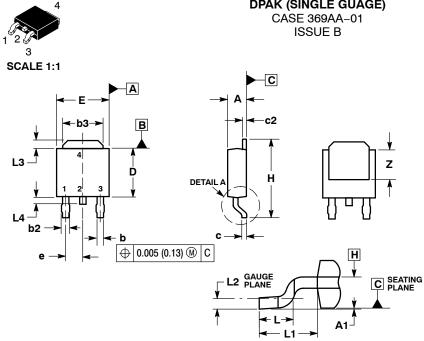
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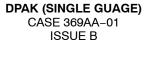
X

xxxxxxxxx = Device Code
A = Assembly Location
IL = Wafer Lot
Y = Year
WW = Work Week

	IPAK (DPAK INSERTION MOUNT)			
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DETAIL A ROTATED 90° CW **DATE 03 JUN 2010**

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

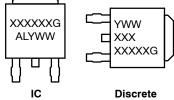
	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74	REF
L2	0.020	0.020 BSC		BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

GENERIC

MARKING DIAGRAM*

STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE STYLE 1: PIN 1. BASE STYLE 2: PIN 1. GATE STYLE 3: PIN 1. ANODE 2. COLLECTOR 3. EMITTER 2. CATHODE 3. ANODE 2. DRAIN 3. SOURCE 4. COLLECTOR 4. DRAIN CATHODE STYLE 5: STYLE 6: STYLE 7: PIN 1. GATE 2. ANODE 3. CATHODE PIN 1. GATE 2. COLLECTOR PIN 1. MT1 2. MT2 3. GATE 3. EMITTER 4. ANODE COLLECTOR

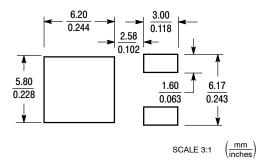
XXXXXXG



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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